

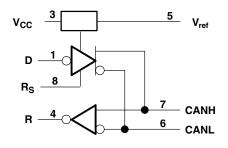
3.3-V CAN TRANSCEIVERS

FEATURES

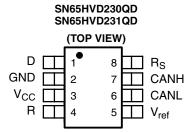
- Qualified for Automotive Applications
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Operates With a 3.3-V Supply
- Low Power Replacement for the PCA82C250 Footprint
- Bus/Pin ESD Protection Exceeds 15-kV HBM
- Controlled Driver Output Transition Times for Improved Signal Quality on the SN65HVD230Q and SN65HVD231Q
- Unpowered Node Does Not Disturb the Bus
- Compatible With the Requirements of the ISO 11898 Standard
- Low-Current SN65HVD230Q Standby Mode 370 μA Typical
- Low-Current SN65HVD231Q Sleep Mode 0.1 μA Typical
- Designed for Signaling Rates[‡] Up To 1 Megabit/Second (Mbps)

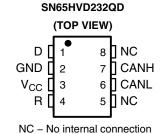
logic diagram (positive logic)

SN65HVD230Q, SN65HVD231Q Logic Diagram (Positive Logic)

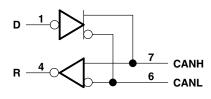


- Thermal Shutdown Protection
- Open-Circuit Fail-Safe Design





SN65HVD232Q Logic Diagram (Positive Logic)





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

[‡] The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

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DESCRIPTION

The SN65HVD230Q, SN65HVD231Q, and SN65HVD232Q controller area network (CAN) transceivers are designed for use with the Texas Instruments TMS320Lx240x 3.3-V DSPs with CAN controllers, or with equivalent devices. They are intended for use in applications employing the CAN serial communication physical layer in accordance with the ISO 11898 standard. Each CAN transceiver is designed to provide differential transmit capability to the bus and differential receive capability to a CAN controller at speeds up to 1 Mbps.

Designed for operation in especially-harsh environments, these devices feature cross-wire protection, loss-of-ground and overvoltage protection, overtemperature protection, as well as wide common-mode range.

The transceiver interfaces the single-ended CAN controller with the differential CAN bus found in industrial, building automation, and automotive applications. It operates over a -2-V to 7-V common-mode range on the bus, and it can withstand common-mode transients of ± 25 V.

On the SN65HVD230Q and SN65HVD231Q, R_S (pin 8) provides three different modes of operation: high-speed, slope control, and low-power modes. The high-speed mode of operation is selected by connecting pin 8 to ground, allowing the transmitter output transistors to switch on and off as fast as possible with no limitation on the rise and fall slopes. The rise and fall slopes can be adjusted by connecting a resistor to ground at pin 8, since the slope is proportional to the pin's output current. This slope control is implemented with external resistor values of 10 k Ω , to achieve a 15-V/ μ s slew rate, to 100 k Ω , to achieve a 2-V/ μ s slew rate.

The circuit of the SN65HVD230Q enters a low-current standby mode during which the driver is switched off and the receiver remains active if a high logic level is applied to R_S (pin 8). The DSP controller reverses this low-current standby mode when a dominant state (bus differential voltage > 900 mV typical) occurs on the bus.

The unique difference between the SN65HVD230Q and the SN65HVD231Q is that both the driver and the receiver are switched off in the SN65HVD231Q when a high logic level is applied to R_S (pin 8) and remain in this sleep mode until the circuit is reactivated by a low logic level on R_S .

The V_{ref} (pin 5 on the SN65HVD230Q and SN65HVD231Q) is available as a $V_{CC}/2$ voltage reference.

The SN65HVD232Q is a basic CAN transceiver with no added options; pins 5 and 8 are NC, no connection.

AVAILABLE OPTIONS†‡

FUNCTION NUMBER	LOW POWER MODE	INTEGRATED SLOPE CONTROL	Vref PIN
'230	370-μA standby mode	Yes	Yes
'231	10-μA sleep mode	Yes	Yes
'232	No standby or sleep mode	No	No

PART NUMBER	Q100	T _A	MARKED AS:
SN65HVD230QD	No		HV230Q
SN65HVD231QD	No	–40°C to 125°C	HV231Q
SN65HVD232QD	No	120 0	HV232Q
SN65HVD230QDQ1	Yes	–40°C to 125°C	230Q1
SN65HVD231QDQ1	Yes		231Q1
SN65HVD232QDQ1	Yes] '23 0	232Q1

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

The D package is available taped and reeled. Add the suffix R to device type (e.g., SN65HVD230QDRQ1).



[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

Function Tables

DRIVER (SN65HVD230Q, SN65HVD231Q)

INDUT D	_	OUT	PUTS	DUO OTATE
INPUT D	R _S	CANH	CANL	BUS STATE
L	V .40V	Н	L	Dominant
Н	$V_{(Rs)} < 1.2 V$	Z	Z	Recessive
Open	X	Z	Z	Recessive
X	$V_{(Rs)} > 0.75 V_{CC}$	Z	Z	Recessive

H = high level; L = low level; X = irrelevant; ? = indeterminate

DRIVER (SN65HVD232Q)

	•		<u> </u>	
INDUT D	OUTPUTS		DUC CTATE	
INPUT D	CANH	CANL	BUS STATE	
L	Н	L	Dominant	
Н	Z	Z	Recessive	
Open	Z	Z	Recessive	

H = high level; L = low level

RECEIVER (SN65HVD230Q)

DIFFERENTIAL INPUTS	R _S	OUTPUT R
$V_{ID} \ge 0.9 \text{ V}$	Х	L
0.5 V < V _{ID} < 0.9 V	Х	?
$V_{ID} \le 0.5 \text{ V}$	Х	Н
Open	X	Н

H = high level; L = low level; X = irrelevant; ? = indeterminate

RECEIVER (SN65HVD231Q)

DIFFERENTIAL INPUTS	R _S	OUTPUT R
V _{ID} ≥ 0.9 V		L
0.5 V < V _{ID} < 0.9 V	V _(Rs) < 1.2 V	?
$V_{ID} \le 0.5 \text{ V}$		Н
Х	$V_{(Rs)} > 0.75 V_{CC}$	Н
Х	$1.2 \text{ V} < \text{V}_{(Rs)} < 0.75 \text{ V}_{CC}$?
Open	Х	Н

H = high level; L = low level; X = irrelevant; ? = indeterminate

RECEIVER (SN65HVD232Q)

DIFFERENTIAL INPUTS	OUTPUT R
V _{ID} ≥ 0.9 V	L
$0.5 \text{ V} < \text{V}_{\text{ID}} < 0.9 \text{ V}$?
V _{ID} ≤ 0.5 V	Н
Open	Н

H = high level; L = low level; X = irrelevant; ? = indeterminate



Function Tables (Continued)

TRANSCEIVER MODES (SN65HVD230Q, SN65HVD231Q)

V _(Rs)	OPERATING MODE	
V _(RS) > 0.75 V _{CC}	Standby	
10 k Ω to 100 k Ω to ground	Slope control	
V _(RS) < 1 V	High speed (no slope control)	

Terminal Functions

SN65HVD230Q, SN65HVD231Q			
TERMINAL		DESCRIPTION	
NAME	NO.	DESCRIPTION	
CANL	6	Low bus output	
CANH	7	High bus output	
D	1	Driver input	
GND	2	Ground	
R	4	Receiver output	
R _S	8	Standby/slope control	
V _{CC}	3	Supply voltage	
V_{ref}	5	Reference output	

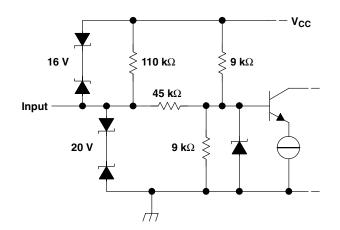
SN65HVD232Q			
TERMINAL		DECODIDEION	
NAME	NO.	DESCRIPTION	
CANL	6	Low bus output	
CANH	7	High bus output	
D	1	Driver input	
GND	2	Ground	
NC	5, 8	No connection	
R	4	Receiver output	
V _{CC}	3	Supply voltage	



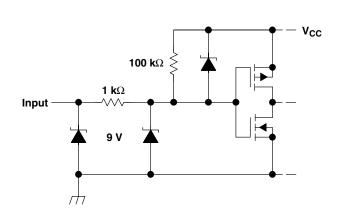
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equivalent input and output schematic diagrams

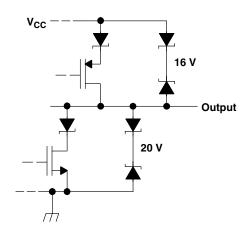
CANH and CANL Inputs



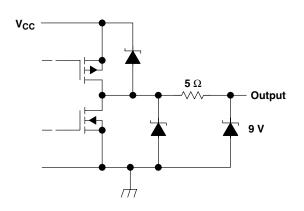
D Input



CANH and CANL Outputs



R Output



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absolute maximum ratings over operating free-air temperature (see Note 1) (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–7 V to	16 V
Voltage input range, transient pulse, CANH and CANL, throu	$_{ m lgh}$ 100 Ω (see Figure 7) $_{ m color}$ –25 V to	25 V
Input voltage range, V _I (D or R)	–0.5 V to V _{CC} +	0.5 V
Electrostatic discharge: Human body model (see Note 2)	CANH, CANL and GND 1	5 kV
	All pins	.5 kV
Charged-device model (see Note 3)	All pins	4 kV
Continuous total power dissipation	See Dissipation Rating	table
Storage temperature range, T _{stq}	–65°C to 1	50°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 secon		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
 - 2. Tested in accordance with JEDEC Standard 22, Test Method A114-A.
 - 3. Tested in accordance with JEDEC Standard 22, Test Method C101.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW

[‡] This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

recommended operating conditions

PARAMETER		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		3		3.6	V
Voltage at any bus terminal (common mode) V _{IC}		-2§		7	V
Voltage at any bus terminal (separately) V _I		-2.5		7.5	V
High-level input voltage, V _{IH}	D, R	2			V
Low-level input voltage, V _{IL}	D, R			0.8	V
Differential input voltage, V _{ID} (see Figure 5)		-6		6	V
V _(RS)	0		V_{CC}	V	
V _(RS) for standby or sleep		0.75 V _{CC}		V_{CC}	V
Rs wave-shaping resistance		0		100	kΩ
High level autority common l	Driver	-40			
High-level output current, I _{OH}	Receiver	-8			mA
I am land adam a amand I	Driver			48	
Low-level output current, I _{OL}				8	mA
Operating free-air temperature, T _A		-40		125	°C

[§] The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.



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driver electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARA	METER		TEST CONDITIONS			MIN	TYP†	MAX	UNIT	
V		Daminant	V		$V_1 = 0 V_1$ CANH		CANH	2.45		V_{CC}	
V _{OH}	Bus output	Dominant		See Figure	1 and Figure 3	CANL	0.5		1.25	V	
V	voltage	Danasina		$V_1 = 3 V_1$		CANH		2.3		V	
V _{OL}		Recessive		See Figure	1 and Figure 3	CANL		2.3			
.,		Daminant		$V_I = 0 V$,	See Figure 1		1.5	2	3	.,	
$V_{OD(D)}$	Differential output	Dominant	Dominant		V _I = 0 V, See Figure 2		1.2	2	3	V	
, , , , , , , , , , , , , , , , , , ,	voltage	D	. \		V _I = 3 V, See Figure 1		-120	0	12	mV	
V _{OD(R)}		Recessive		V _I = 3 V, No load			-0.5	-0.2	0.05	V	
I _{IH}	High-level input cur	rent		V _I = 2 V			-30			μΑ	
I _{IL}	Low-level input curi	rent		$V_{I} = 0.8 \text{ V}$			-30			μΑ	
	Object always a colorest			$V_{CANH} = -2 V$			-250		250	A	
los	Short-circuit output	current		V _{CANL} = 7 V			-250		250	mA	
Co	Output capacitance)		See receiver							
		Standby	SN65HVD230Q	V V		_		370	600		
.	Sleep SN65HVD231C		SN65HVD231Q	$V_{(RS)} = V_{CC}$				0.1		μΑ	
Icc	Supply current	All devises	Dominant	$V_I = 0 V$,	No load	Dominant		10	17	A	
		All devices	Recessive	$V_I = V_{CC}$,	No load	Recessive		10	17	mA	

[†] All typical values are at 25°C and with a 3.3-V supply.

driver switching characteristics at T_A = 25°C (unless otherwise noted) SN65HVD230Q and SN65HVD231Q

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT	
		V _(RS) = 0 V			35	85	
t _{PLH}	Propagation delay time, low-to-high-level output	R_S with 10 $k\Omega$ to ground			70	125	ns
		R_S with 100 $k\Omega$ to ground			500	870	
		V _(RS) = 0 V			70	120	
t _{PHL}	Propagation delay time, high-to-low-level output	R_S with 10 $k\Omega$ to ground			130	180	ns
		R_S with 100 $k\Omega$ to ground			870	1200	
		$V_{(RS)} = 0 V$			35		
t _{sk(p)}	Pulse skew ($ t_{P(HL)} - t_{P(LH)} $)	R_S with 10 $k\Omega$ to ground	C _L = 50 pF, See Figure 4		60		ns
	()	R_S with 100 $k\Omega$ to ground	3ee rigule 4		370		
t _r	Differential output signal rise time	у оу		25	50	100	ns
t _f	Differential output signal fall time	$V_{(RS)} = 0 V$		40	55	80	ns
t _r	Differential output signal rise time	5 W 10101		80	120	160	ns
t _f	Differential output signal fall time	R_S with 10 k Ω to ground		80	125	150	ns
t _r	Differential output signal rise time	5 W 1551 51		600	800	1200	ns
t _f	Differential output signal fall time	R_S with 100 k Ω to ground		600	825	1000	ns



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driver switching characteristics at T_A = 25°C (unless otherwise noted)

SN65HVD232Q

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high-level output			35	85	ns
t_{PHL}	Propagation delay time, high-to-low-level output			70	120	ns
t _{sk(p)}	Pulse skew (t _{P(HL)} - t _{P(LH)})	C _L = 50 pF, See Figure 4		35		ns
t _r	Differential output signal rise time		25	50	100	ns
t _f	Differential output signal fall time		40	55	80	ns

receiver electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS			TYP†	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage				750	900	mV
V_{IT-}	Negative-going input threshold voltage	See Table 1		500	650		
V_{hys}	Hysteresis voltage (V _{IT+} V _{IT-})				100		mV
V _{OH}	High-level output voltage	$-6 \text{ V} \le \text{V}_{\text{ID}} \le 500 \text{ mV}, \text{ I}_{\text{O}} = -8 \text{ mA}$	2.4			٧	
V_{OL}	Low-level output voltage	$900 \text{ mV} \le V_{ID} \le 6 \text{ V}, I_{O} = 8 \text{ mA}, S$	ee Figure 5			0.4	
	Bus input current	V _{IH} = 7 V		100		250	
		V _{IH} = 7 V, V _{CC} = 0 V	Other input at 0 V,	100		350	μΑ
ΙĮ		V _{IH} = −2 V	D = 3 V	-200		-30	
		$V_{IH} = -2 \text{ V}, V_{CC} = 0 \text{ V}$		-100		-20	μΑ
Ci	CANH, CANL input capacitance	Pin-to-ground, V _I = 0.4 sin(4E6πt) + 0.5 V	V _(D) = 3 V,		32		pF
C_{diff}	Differential input capacitance	Pin-to-pin, V _I = 0.4 sin(4E6πt) + 0.5 V	$V_{(D)} = 3 V,$		16		pF
R _{diff}	Differential input resistance	Pin-to-pin, $V_{(D)} = 3 \text{ V}$		40	70	100	kΩ
R _T	CANH, CANL input resistance			20	35	50	kΩ
I _{CC}	Supply current	See driver			_		

[†] All typical values are at 25°C and with a 3.3-V supply.

receiver switching characteristics at T_A = 25°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
t _{PLH}	Propagation delay time, low-to-high-level output				35	50	ns
t _{PHL}	Propagation delay time, high-to-low-level output		See Figure 6		35	50	ns
t _{sk(p)}	Pulse skew (t _{P(HL)} - t _{P(LH)})				10	ns	
t _r	Output signal rise time	0		1.5		ns	
t _f	Output signal fall time		See Figure 6		1.5		ns
t _{(loop})	Total loop delay, driver input to receiver output	$V_{(RS)} = 0 V$			70	135	
t _(loop)	Total loop delay, driver input to receiver output	R_S with 10 $k\Omega$ to ground]		105	175	ns
t _(loop)	Total loop delay, driver input to receiver output	R_S with 100 $k\Omega$ to ground			535	920	



device control-pin characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT	
t _(WAKE)	SN65HVD230Q wake-up time from standby mode with $\rm R_{\rm S}$	See Figure 8		0.55	1.5	μS	
(**/ ((*)	SN65HVD231Q wake-up time from sleep mode with R _S	Ů			3	μS	
V	Deference entrutualtere	$-5 \mu\text{A} < I_{(Vref)} < 5 \mu\text{A}$	0.45 V _{CC}		0.55 V _{CC}	V	
V_{ref}	Reference output voltage	$-50 \mu\text{A} < I_{(Vref)} < 50 \mu\text{A}$	0.4 V _{CC}		0.6 V _{CC}	٧	
I _(RS)	Input current for high-speed	V _(RS) < 1 V	-450		0	μΑ	

[†] All typical values are at 25°C and with a 3.3 V supply.

PARAMETER MEASUREMENT INFORMATION

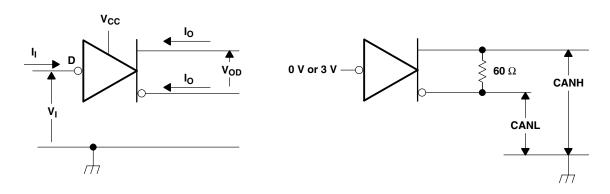


Figure 1. Driver Voltage and Current Definitions

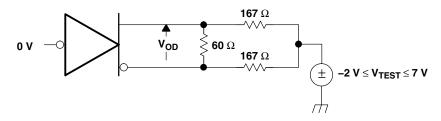


Figure 2. Driver V_{OD}

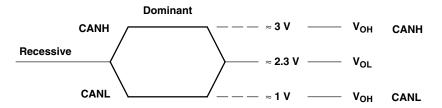
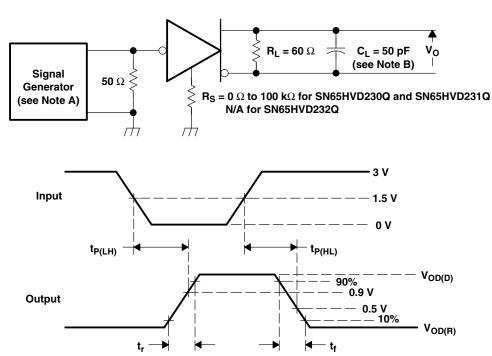


Figure 3. Driver Output Voltage Definitions



PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 500 kHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.

B. C_L includes probe and jig capacitance.

Figure 4. Driver Test Circuit and Voltage Waveforms

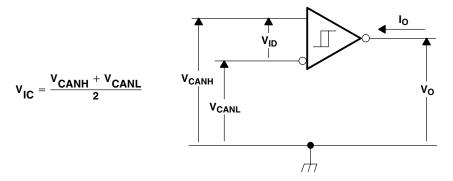
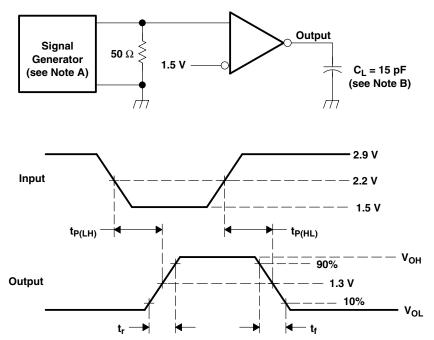


Figure 5. Receiver Voltage and Current Definitions



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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 500 kHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 7 ns, $t_f \leq$ 8 ns, $t_$
 - B. C_L includes probe and jig capacitance.

Figure 6. Receiver Test Circuit and Voltage Waveforms

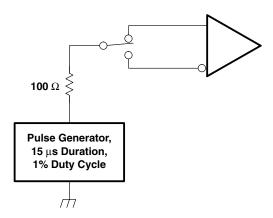


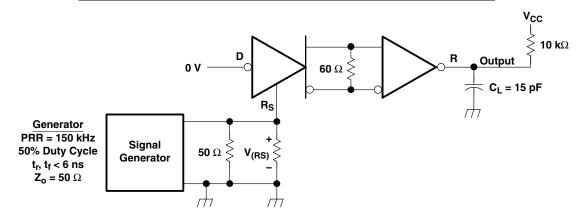
Figure 7. Overvoltage Protection



PARAMETER MEASUREMENT INFORMATION

Table 1. Receiver Characteristics Over Common Mode With V(RS) at 1.2 V

V _{IC}	V _{ID}	V _{CANH}	V _{CANL}	R OU	TPUT
–2 V	900 mV	–1.55 V	−2.45 V	L	
7 V	900 mV	8.45 V	6.55 V	L] ,,
1 V	6 V	4 V	–2 V	L	V _{OL}
4 V	6 V	7 V	1 V	L	
–2 V	500 mV	–1.75 V	–2.25 V	Н	
7 V	500 mV	7.25 V	6.75 V	Н	
1 V	-6 V	–2 V	4 V	Н	V _{OH}
4 V	-6 V	1 V	7 V	Н	
Х	Х	Open	Open	Н	1



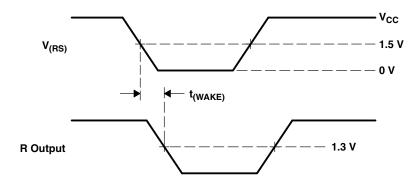
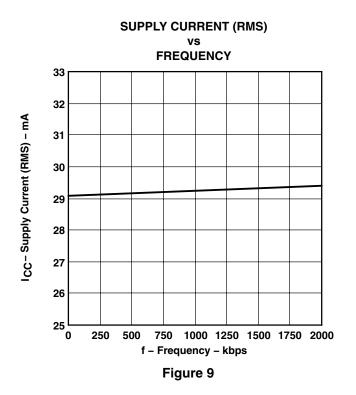
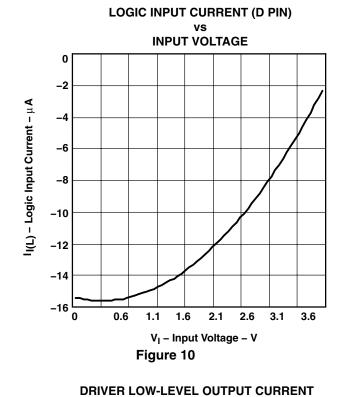


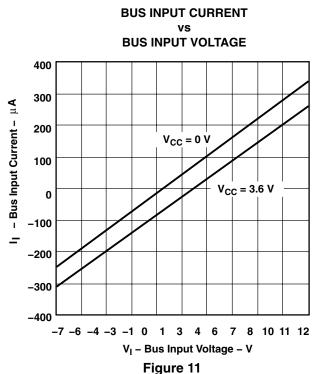
Figure 8. $t_{(WAKE)}$ Test Circuit and Voltage Waveforms



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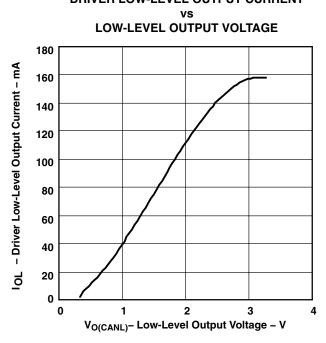
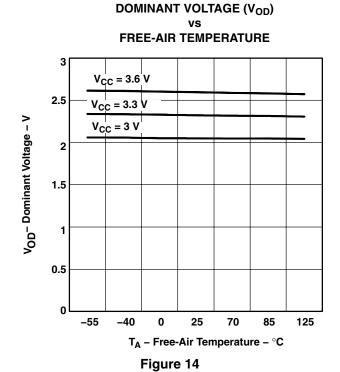


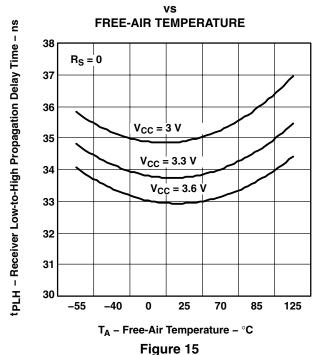
Figure 12

DRIVER HIGH-LEVEL OUTPUT CURRENT HIGH-LEVEL OUTPUT VOLTAGE 120 I OH - Driver High-Level Output Current - mA 100 80 60 40 20 0 0 0.5 2 1.5 2.5 3 3.5 V_{O(CANH)} - High-Level Output Voltage - V

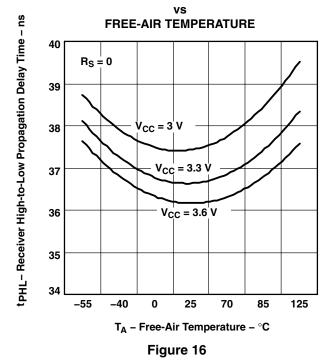


RECEIVER LOW-TO-HIGH PROPAGATION DELAY TIME

Figure 13

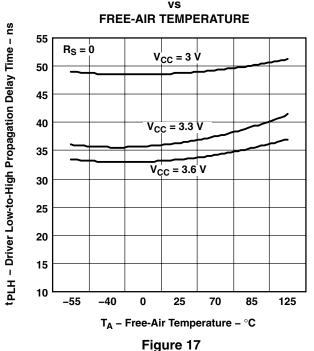


RECEIVER HIGH-TO-LOW PROPAGATION DELAY TIME





DRIVER LOW-TO-HIGH PROPAGATION DELAY TIME



DRIVER HIGH-TO-LOW PROPAGATION DELAY TIME

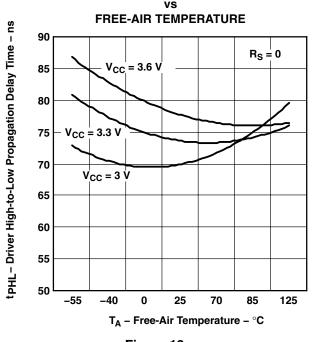
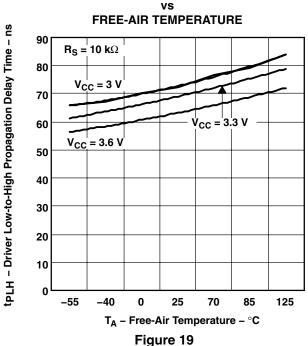
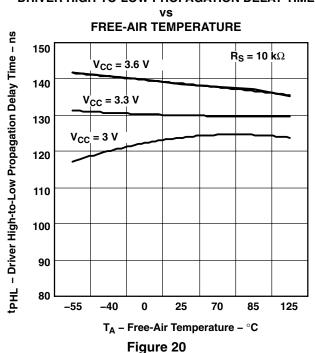


Figure 18

DRIVER LOW-TO-HIGH PROPAGATION DELAY TIME



DRIVER HIGH-TO-LOW PROPAGATION DELAY TIME





DRIVER LOW-TO-HIGH PROPAGATION DELAY TIME

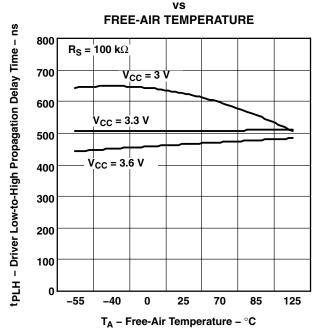


Figure 21

DRIVER HIGH-TO-LOW PROPAGATION DELAY TIME

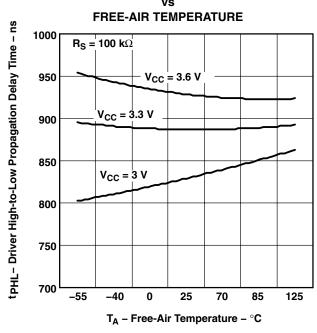


Figure 22

DRIVER OUTPUT CURRENT

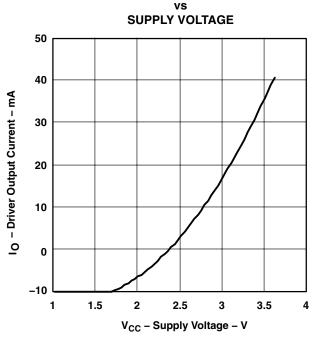


Figure 23

DIFFERENTIAL DRIVER OUTPUT FALL TIME vs Source Resistance (R_S)

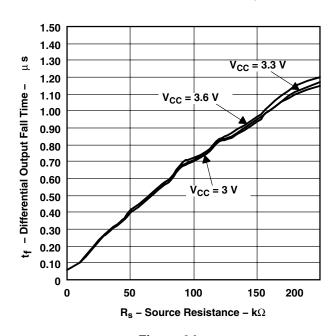


Figure 24



REFERENCE VOLTAGE vs REFERENCE CURRENT 3 2.5 V_{CC} = 3.6 V V_{CC} = 3 V 0.5 0 -50 -50 5 5 50

Figure 25

APPLICATION INFORMATION

 I_{ref} - Reference Current - μ A

This application provides information concerning the implementation of the physical medium attachment layer in a CAN network according to the ISO 11898 standard. It presents a typical application circuit and test results, as well as discussions on slope control, total loop delay, and interoperability in 5-V systems.

introduction

ISO 11898 is the international standard for high-speed serial communication using the controller area network (CAN) bus protocol. It supports multimaster operation, real-time control, programmable data rates up to 1 Mbps, and powerful redundant error checking procedures that provide reliable data transmission. It is suited for networking *intelligent* devices as well as sensors and actuators within the rugged electrical environment of a machine chassis or factory floor. The SN65HVD230Q family of 3.3-V CAN transceivers implement the lowest layers of the ISO/OSI reference model. This is the interface with the physical signaling output of the CAN controller of the Texas Instruments TMS320Lx240x 3.3-V DSPs, as illustrated in Figure 26.



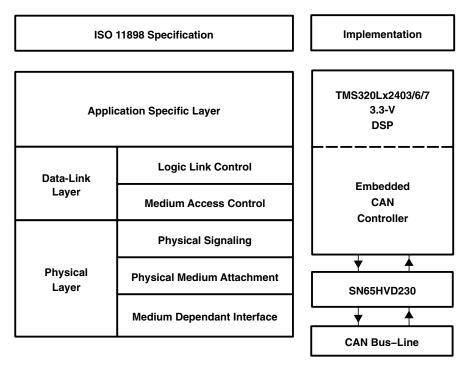


Figure 26. The Layered ISO 11898 Standard Architecture

The SN65HVD230Q family of CAN transceivers are compatible with the ISO 11898 standard; this ensures interoperability with other standard-compliant products.

application of the SN65HVD230Q

Figure 27 illustrates a typical application of the SN65HVD230Q family. The output of a DSP's CAN controller is connected to the serial driver input, pin D, and receiver serial output, pin R, of the transceiver. The transceiver is then attached to the differential bus lines at pins CANH and CANL. Typically, the bus is a twisted pair of wires with a characteristic impedance of 120 Ω , in the standard half-duplex multipoint topology of Figure 28. Each end of the bus is terminated with 120- Ω resistors in compliance with the standard to minimize signal reflections on the bus.



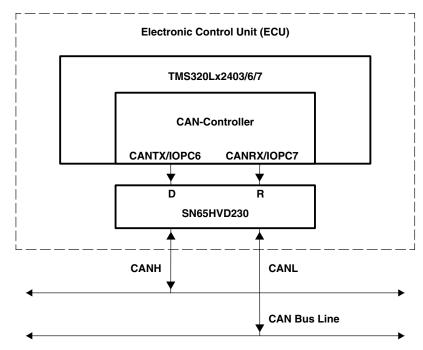


Figure 27. Details of a Typical CAN Node

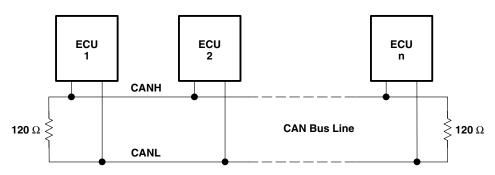


Figure 28. Typical CAN Network

The SN65HVD230Q/231Q/232Q 3.3-V CAN transceivers provide the interface between the 3.3-V TMS320Lx2403/6/7 CAN DSPs and the differential bus line, and are designed to transmit data at signaling rates up to 1 Mbps as defined by the ISO 11898 standard.

features of the SN65HVD230Q, SN65HVD231Q, and SN65HVD232Q

The SN65HVD230Q/231Q/232Q are pin-compatible (but not functionally identical) with one another and, depending upon the application, may be used with identical circuit boards.

These transceivers feature 3.3-V operation and standard compatibility with signaling rates up to 1 Mbps, and also offer 16-kV HBM ESD protection on the bus pins, thermal shutdown protection, bus fault protection, and open-circuit receiver failsafe. The failsafe design of the receiver assures a logic high at the receiver output if the bus wires become open circuited. If a high ambient operating environment temperature or excessive output current result in thermal shutdown, the bus pins become high impedance, while the D and R pins default to a logic high.



features of the SN65HVD230Q, SN65HVD231Q, and SN65HVD232Q (continued)

The bus pins are also maintained in a high-impedance state during low V_{CC} conditions to ensure glitch-free power-up and power-down bus protection for hot-plugging applications. This high-impedance condition also means that an unpowered node will not disturb the bus. Transceivers without this feature usually have a very low output impedance. This results in a high current demand when the transceiver is unpowered, a condition that could affect the entire bus.

operating modes

R_S (pin 8) of the SN65HVD230Q and SN65HVD231Q provides for three different modes of operation: high-speed mode, slope-control mode, and low-power standby mode.

high-speed mode

The high-speed mode can be selected by applying a logic low to Rs (pin 8). The high-speed mode of operation is commonly employed in industrial applications. High-speed allows the output to switch as fast as possible with no internal limitation on the output rise and fall slopes. The only limitations of the high-speed operation are cable length and radiated emission concerns, each of which is addressed by the slope control mode of operation.

If the low-power standby mode is to be employed in the circuit, direct connection to a DSP output pin can be used to switch between a logic-low level (< 1 V) for high speed mode operation, and the logic-high level ($> 0.75 \text{ V}_{CC}$) for standby mode operation. Figure 29 shows a typical DSP connection, and Figure 30 shows the SN65HVD230Q driver output signal in high-speed mode on the CAN bus.

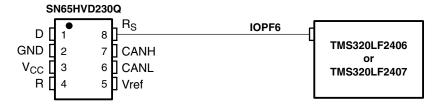


Figure 29. R_S (Pin 8) Connection to a TMS320LF2406/07 for High-Speed or Standby Mode Operation



high-speed mode (continued)

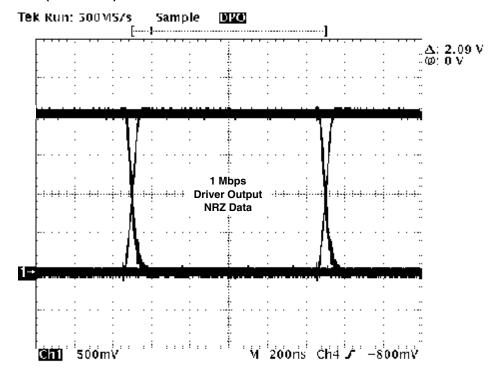


Figure 30. Typical SN65HVD230Q High-Speed Mode Output Waveform Into a 60- Ω Load

slope-control mode

Electromagnetic compatibility is essential in many applications using unshielded bus cable to reduce system cost. To reduce the electromagnetic interference generated by fast rise times and resulting harmonics, the rise and fall slopes of the SN65HVD230Q and SN65HVD231Q driver outputs can be adjusted by connecting a resistor from R_S (pin 8) to ground or to a logic low voltage, as shown in Figure 31. The slope of the driver output signal is proportional to the pin's output current. This slope control is implemented with an external resistor value of 10 k Ω to achieve a \approx 15 V/ μ s slew rate, and up to 100 k Ω to achieve a \approx 2.0 V/ μ s slew rate as displayed in Figure 32. Typical driver output waveforms from a pulse input signal with and without slope control are displayed in Figure 33. A pulse input is used rather than NRZ data to clearly display the actual slew rate.

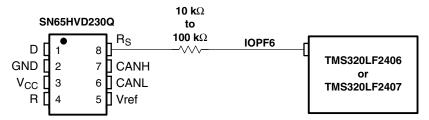


Figure 31. Slope-Control or Standby Mode Connection to a DSP



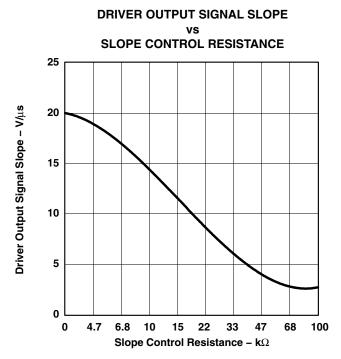


Figure 32. SN65HVD230Q Driver Output Signal Slope vs Slope Control Resistance Value

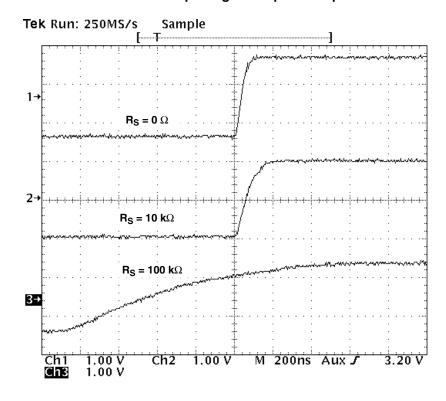


Figure 33. Typical SN65HVD230Q 250-kbps Output Pulse Waveforms With Slope Control



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APPLICATION INFORMATION

standby mode (listen only mode) of the SN65HVD230Q

If a logic high (> $0.75 \ V_{CC}$) is applied to R_S (pin 8) in Figures 29 and 31, the circuit of the SN65HVD230Q enters a low-current, *listen only* standby mode during which the driver is switched off and the receiver remains active. In this *listen only* state, the transceiver is completely passive to the bus. It makes no difference if a slope control resistor is in place as shown in Figure 31. The DSP can reverse this low-power standby mode when the rising edge of a dominant state (bus differential voltage > 900 mV typical) occurs on the bus. The DSP, sensing bus activity, reactivates the driver circuit by placing a logic low (< $1.2 \ V$) on R_S (pin 8).

the babbling idiot protection of the SN65HVD231Q

Occasionally, a runaway CAN controller unintentionally sends messages that completely tie up the bus (what is referred to in CAN jargon as a babbling idiot). When this occurs, the DSP can engage the *listen-only* standby mode to disengage the driver and release the bus, even when access to the CAN controller has been lost. When the driver circuit is deactivated, its outputs default to a high-impedance state.

sleep mode of the SN65HVD231Q

The unique difference between the SN65HVD230Q and the SN65HVD231Q is that both driver and receiver are switched off in the SN65HVD231Q when a logic high is applied to R_S (pin 8). The device remains in a very low power-sleep mode until the circuit is reactivated with a logic low applied to R_S (pin 8). While in this sleep mode, the bus pins are in a high-impedance state, while the D and R pins default to a logic high.

loop propagation delay

Transceiver loop delay is a measure of the overall device propagation delay, consisting of the delay from the driver input to the differential outputs, plus the delay from the receiver inputs to its output.

The loop delay of the transceiver displayed in Figure 34 increases accordingly when slope control is being used. This increased loop delay means that the total bus length must be reduced to meet the CAN bit-timing requirements of the overall system. The loop delay becomes $\approx\!100$ ns when employing slope control with a 10-k Ω resistor, and $\approx\!500$ ns with a 100-k Ω resistor. Therefore, considering that the rule-of-thumb propagation delay of typical bus cable is 5 ns/m, slope control with the 100-k Ω resistor decreases the allowable bus length by the difference between the 500-ns max loop delay and the loop delay with no slope control, 70.7 ns. This equates to (500–70.7 ns)/5 ns, or approximately 86 m less bus length. This slew-rate/bus length trade-off to reduce electromagnetic interference to adjoining circuits from the bus can also be solved with a high-quality shielded bus cable.



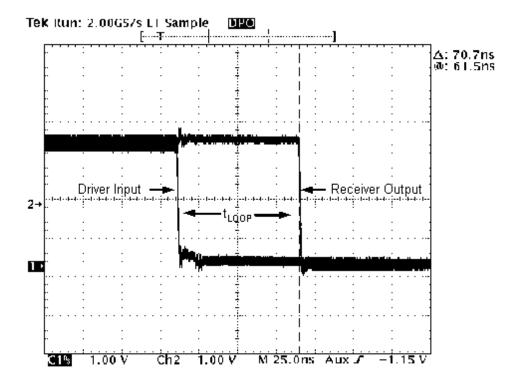


Figure 34. 70.7-ns Loop Delay Through the SN65HVD230Q With $R_S = 0$



interoperability with 5-V CAN systems

It is essential that the 3.3-V SN65HVD230Q family performs seamlessly with 5-V transceivers because of the large number of 5-V devices installed. Figure 35 displays a test bus of a 3.3-V node with the SN65HVD230Q, and three 5-V nodes: one for each of TI's SN65LBC031 and UC5350 transceivers, and one using a competitor X250 transceiver.

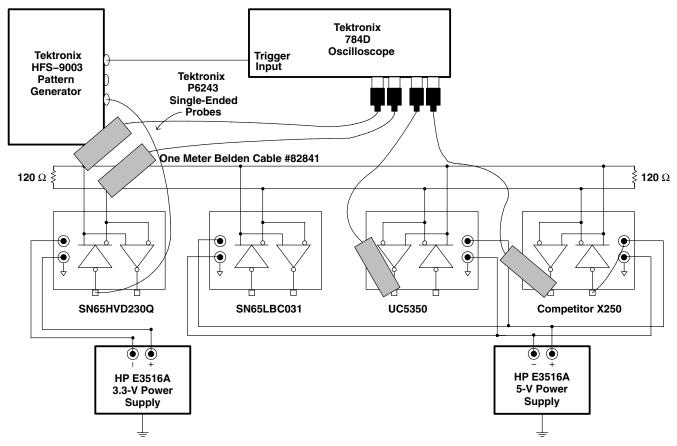


Figure 35. 3.3-V/5-V CAN Transceiver Test Bed



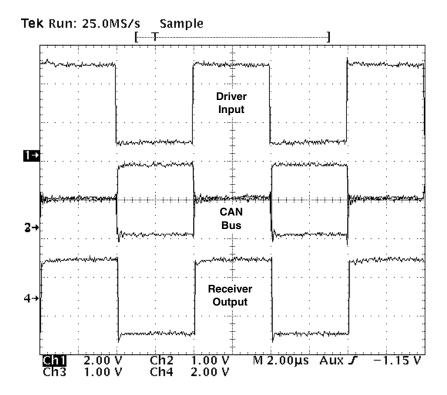


Figure 36. SN65HVD230Q's Input, CAN Bus, and X250's RXD Output Waveforms

Figure 36 displays the SN65HVD230Q's input signal, the CAN bus, and the competitor X250's receiver output waveforms. The input waveform from the Tektronix HFS-9003 Pattern Generator in Figure 35 to the SN65HVD230Q is a 250-kbps pulse for this test. The circuit is monitored with Tektronix P6243, 1-GHz single-ended probes in order to display the CAN dominant and recessive bus states.

Figure 36 displays the 250-kbps pulse input waveform to the SN65HVD230Q on channel 1. Channels 2 and 3 display CANH and CANL respectively, with their recessive bus states overlaying each other to clearly display the dominant and recessive CAN bus states. Channel 4 is the receiver output waveform of the competitor X250.







17-Oct-2012

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
SN65HVD230QDG4Q1	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN65HVD230QDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN65HVD231QDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN65HVD231QDRQ1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN65HVD232QDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN65HVD232QDRQ1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	

⁽¹⁾ The marketing status values are defined as follows:

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LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

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17-Oct-2012

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OTHER QUALIFIED VERSIONS OF SN65HVD230Q-Q1, SN65HVD231Q-Q1, SN65HVD232Q-Q1:

• Catalog: SN65HVD230Q, SN65HVD231Q, SN65HVD232Q

NOTE: Qualified Version Definitions:

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Catalog - TI's standard catalog product

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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